

Article

Small-Area Radiofrequency-Energy-Harvesting Integrated Circuits for Powering Wireless Sensor Networks

Guo-Ming Sung ^{1,2,*}, Chao-Kong Chung ^{1,3}, Yu-Jen Lai ¹ and Jin-Yu Syu ¹

- ¹ Department of Electrical Engineering, National Taipei University of Technology, Taipei 10608, Taiwan; james591126@gmail.com (C.-K.C.); boredcity48@gmail.com (Y.-J.L.); j887110@gmail.com (J.-Y.S.)
- ² Research and Development Centre for Smart Textile Technology, National Taipei University of Technology, 1, Sec. 3, Zhongxiao E. Rd., Taipei 10608, Taiwan
- ³ General Manager Office, Goodfield Technology Co., Ltd., 46, Lane 55, Sec. 3, Zhiyuan Rd., Taipei 11265, Taiwan
- * Correspondence: gmsung@ntut.edu.tw; Tel.: +886-2-27712171 (ext. 2121); Fax: +886-2-27317187

Received: 23 February 2019; Accepted: 9 April 2019; Published: 12 April 2019



Abstract: This study presents a radiofrequency (RF)-energy-harvesting integrated circuit (IC) for powering wireless sensor networks with a wireless transmitter with an industrial, scientific, and medical (ISM) of 915 MHz. The proposed IC comprises an RF-direct current (DC) rectifier, an over-voltage protection circuit, a low-power low-dropout (LDO) voltage regulator, and a charger control circuit. In the RF-DC rectifier circuit, a six-stage Dickson voltage multiplier circuit is used to improve the received RF signal to a DC voltage by using native MOS with a small threshold voltage. The over-voltage protection circuit is used to prevent a high-voltage breakdown phenomenon from the RF front-end circuit, particularly for near-field communication. A low-power LDO regulator is designed to provide stable voltage by using zero frequency compensation and a voltage-trimming feedback. Charging current is amplified N times by using a current mirror to rapidly and stably charge a battery in the proposed charger control circuit. The obtained results revealed that the maximum power conversion efficiency of the proposed RF-energy-harvesting IC was 40.56% at an input power of –6 dBm, an output voltage of 1.5 V, and a load of 30 k Ω . A chip area of the RF-energy-harvesting IC was 0.58 × 0.49 mm², including input/output pads, and power consumption was 42 μ W.

Keywords: radiofrequency; ISM 915 MHz; energy-harvesting IC; native MOS; Dickson voltage multiplier; over-voltage protection circuit; low-dropout regulator; charger control circuit

1. Introduction

Energy harvesting for supplying power to low-power electronic devices has recently become mainstream research. The lifetime of a battery can be extended using a developed self-sustainable power supply. Bito et al. designed a flexible wearable radiofrequency (RF) energy harvester for off-the-shelf two-way talk radios of 2 W using inkjet printing technology, and E- and H-field energy harvesters were verified using a light-emitting diode and microcontroller communication module [1]. Tian et al. presents an integrated solution for a flexible direct current (DC)–DC converter by embedding a flexible polyimide printed circuit board and an inductor made of flexible ferrite-polymer composite in a wire [2]. A wearable RF-energy-harvesting device, which comprises a U-shaped dipole antenna, matching network, RF-DC converter, and DC–DC converter, was presented in [3] for supplying power to smart jewelry. This design converts a 915-MHz RF signal into a constant DC output voltage of 3.1 V at an input power of -6 dBm, which is suitable for supplying power to a fitness monitor pendant



under standby mode. An experimental comparison in [3] shows that the Dickson topology has high efficiency at a high input power.

A commercial power supply or battery can be used as a stable power source for providing power to wireless sensor networks (WSNs). However, these power supplies have a finite lifetime, have a large size, incur high maintenance cost, and cause environmental pollution. RF energy harvesting was introduced because of potentially long lifespan, low-power consumption, and small size [4]. In this process, ambient energy is emitted from various sources, such as television (TV), radio, wireless Internet, satellite communication, and base stations, which is converted into feasible DC voltages. WSN devices powered by RF energy can be used in several applications, such as telemetry systems, RF tags, home automation, equipment monitoring, access control, and prolongation of lifespan of powered devices [5,6]. In [7], a five-stage orthogonally switching charge pump rectifier with a voltage boosting network was used for an RF energy harvester. The rectifier provides a DC voltage and power conversion efficiency (*PCE*) of 1.3 V and 33.72%, respectively, with a load of 100 k Ω from an RF source of –13 dBm at an ISM frequency.

The WSNs are fabricated using low-power circuits, particularly by integrating with an antenna and a voltage multiplier for a stable power supply [8,9]. A combination of a two-stage Villard multiplier with a three-stage Dickson voltage multiplier was proposed to increase output voltage and power efficiency [10]. A Villard–Dickson power harvester circuit can produce an output voltage of 4 V with an efficiency of 3.9% and an output voltage of 8.8 V with an efficiency of 14.6% without and with a matching circuit, respectively, at an input signal of 4.1 dBm from a TV station [10]. A microstrip matching circuit and zero-biased diode were used to improve the performance of the designed energy-harvesting device.

The Internet of Things (IoT) is a well-known platform, wherein each physical object is connected to the Internet without requiring human interaction. Few people check for regular supply of power to IoT, excluding WSNs. To supply power to these communication devices for a long duration, a self-sustainable power system is required for complex networks [11]. A feasible technique is to harvest RF energy from external environmental sources, which could be used as an auxiliary power supply for increasing the battery life [12,13]. In general, RF energy-harvesting bands from ISM (900–928 MHz) and WLAN (2.4/5 GHz) have received considerable attention because they can cover cities and countries due to their continuous emission as commercial bands [14–16]. In [17], RF energy harvesting employed a Wi-Fi band at a frequency of 2.4 GHz by using the P21XXCSR-EVB evaluation board from Powercast. Four types of antennas and an RF-energy-harvesting evaluation board are included in this research. Experiments have shown that power losses in air and antennas have a stronger effect on the total efficiency of the system than the losses in the RF energy harvester. The RF-energy-harvesting system can be improved using antenna arrays, particularly for supplying power to low-power sensors and IoT devices.

Most previous studies have used an individual energy-harvesting source to supply power to low-power sensors and IoT devices. However, the available environmental energies affect the input power of the RF transmitter (Powercast Corporation) at a frequency of 2.4 GHz. Sensors and IoT devices are always installed on the ceiling of a room. For uniform RF transmission and increasing communication distance, this study employed a TX91501 RF transmitter from Powercast Corporation [18], which provides an output power of 3 W at an ISM band of 915 MHz, with a maximum transmission distance of 12–15 m. Moreover, a 1-dBi bipolar antenna was used as a receiving antenna to design an RF-energy-harvesting chip. Figure 1 shows the proposed RF-energy-harvesting system, which includes a Powercast transmitter, receiving antenna, RF-energy-harvesting IC, and power source.

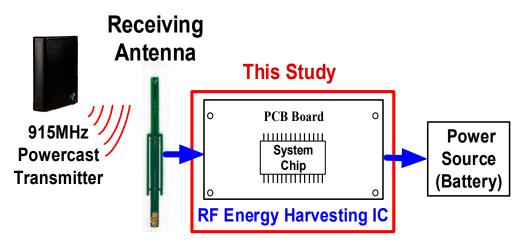


Figure 1. Proposed RF-energy-harvesting system.

The following section elucidates the circuit topology of the designed RF-energy-harvesting IC. Sections 3 and 4 present the simulated and measured results and conclusions, respectively.

2. Circuit Topology of RF-Energy-Harvesting Integrated Circuit

Figure 2 shows a functional diagram of the RF-energy-harvesting IC, which receives RF energy from the receiving antenna, and this energy charges energy storage devices. Thus, the proposed IC is used as a backup stable power source. An off-chip matching network from MuRata Manufacturing Co. Ltd. was used to guarantee maximum power transfer. The RF-DC rectifier received the transferred RF energy from a matching network and converted this energy into DC voltage. An over-voltage protection circuit was then designed to protect the RF-DC rectifier when the output voltage of the designed rectifier was higher than the breakdown voltage [19]. A stable voltage of 1.5 V is passed through the low-power LDO circuit and sent to the charging control circuit for charging storage devices such as a battery.

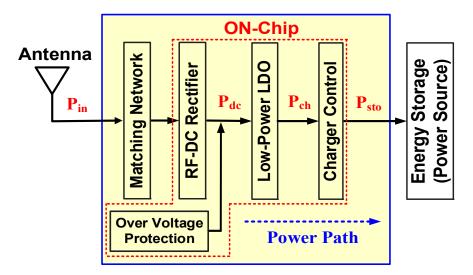


Figure 2. Functional diagram of RF-energy-harvesting IC.

2.1. Matching Network

Because of an antenna impedance of 50 Ω , the input impedance of the matching network must be matched to 50 Ω . This matching circuit is used to not only guarantee maximum power transfer but also obtain maximum conversion efficiency. If the matching network includes capacitor C and inductor L, maximum power transformation is obtained from an antenna to a load. Source impedance R_a must be equal to the conjugate input impedance Z_{in} of the matching network [20]. The maximum output power $P_{L,max}$ can be expressed as follows:

$$P_{L,\max} = \left| I_a^2 \right| \times \Re e[Z_{in}] = \frac{V_a^2}{4R_a} \tag{1}$$

where V_a is the peak voltage of the antenna. I_a and Z_{in} are the input current and input impedance of the matching network, respectively.

In this study, the impedance of the antenna and the input impedance of the RF-DC rectifier were 50 Ω and 240.4 – j473.9 Ω , respectively. The impedance of the matching network must be equal to 50 Ω [21]. Simulations were performed with ADS software and component datasheet provided from MuRata Company, and inductor L, labeled as LQG15HS_02, and capacitor C, labeled as GRM15, were used to complete the matching network. Moreover, authors paid more attention toward self-resonant frequencies (SRFs) for selecting a suitable inductor. The operating frequency of the matching network must be lower than the SRF of the selected inductor. The larger the inductor is, the smaller the SRF is. For example, the minimum SRFs were 1000 and 800 MHz for L \leq 47 μ H and L \geq 56 μ H, respectively. If input power was set to -10 dBm at an operating frequency of 915 MHz, a suitable inductor lower than 47 μ H was selected.

2.2. RF-DC Rectifier

For an N-stage rectifier, a pair of a metal-oxide-semiconductor field-effect transistor [MOSFET (M_P)] and capacitor (C_P) can be considered as a rectifier with a small ripple voltage across C_p . An averaged output voltage of the (p + 1)th stage can be expressed as follows:

$$V_{O(p+1)}(V) = V_{O(p)}(V) + V_{boost}(V),$$
(2)

where $V_{O(p)}$, $V_{O(p+1)}$, and V_{boost} are the output voltage of the p^{th} stage (present voltage), output voltage of the $(p + 1)^{\text{th}}$ stage (next voltage), and incremental voltage of each stage [22], respectively. Approximation in charge computation was used to provide the incremental voltage V_{boost} as follows:

$$V_{boost}(V) = V'_{in} - V_{tn} - \left(\frac{15\pi}{8} \times \frac{I'_{Oeff}\sqrt{2V'_{in}}}{\mu_n C_{ox}(W/L)}\right)^{2/5},$$
(3)

where V'_{in} , V_{tn} , I'_{Oeff} , μ_n , and C_{ox} are an effective voltage amplitude, the threshold voltage of an NMOS transistor, effective loading current, electron mobility, and a gate oxide capacitor, respectively. W and L are the width and length of the MOSFET, respectively. I'_{Oeff} and V'_{in} can be given as follows:

$$I'_{Oeff} = I_0 + \frac{I_{S0}}{\pi} \left(\frac{W}{L}\right) (1 - e^{-V'_{in}/V_T}) (1 + \lambda_{sub} V'_{in}),$$
(4)

$$V_{in}' = \frac{C_t}{C_t + C_{par}} \tag{5}$$

where I_0 , I_{S0} , V_T , λ_{sub} , C_t , C_{par} , and V_{in} are the initial loading current, saturation current, thermal voltage, channel length modulation coefficient, total capacitance value of all capacitors, parasitic capacitance at each stage, and peak amplitude of an input signal of a voltage rectifier, respectively.

If the body effect is ignored, the output voltage of the N-stage rectifier is as follows:

$$V_{ON}(V) = N \times V_{boost}(V) = N \times \left(V'_{in} - V_{tn} - \left(\frac{15\pi}{8} \times \frac{I'_{Oeff} \sqrt{2V'_{in}}}{\mu_n C_{ox}(W/L)} \right)^{2/5} \right), \tag{6}$$

According to the simulation results, many rectifiers are used for achieving the maximum efficiency. For example, 2-, 4-, 6-, 8-, 10-, and 16-stages are designed with respect to different loading currents or peak voltages [22]. For a rapid charging mechanism and stable power source at an operating frequency of 917 MHz, this study adopted a 6-stage voltage rectifier with a small threshold voltage of 0.45 V.

Figure 3 shows a single-ended 6-stage Dickson voltage multiplier, which was published in [22]. It includes 6 diode-connected MOSFETs (M_1 – M_6) and 6 capacitors (C_1 – C_5 and C_L). All transistors and capacitors are identical. A bottom plate, which is marked using a bold line, exhibited a large parasitic capacitance. It is grounded to reduce loss or is connected to the input terminal RF_{in}, which is fed from the matching network.

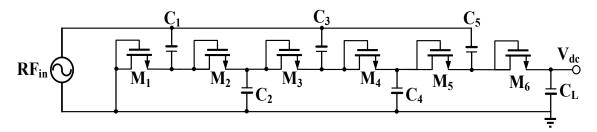


Figure 3. Six-stage Dickson voltage multiplier circuit.

If the input signal of the voltage rectifier was sinusoidal with $RF_{in} = V_{in} \cos 2\pi ft$, where V_{in} and f are respectively the peak amplitude and operating frequency, the DC output voltage V_{dc} could be obtained for a charge transfer with a load capacitor C_L . The capacitor is sufficiently large to store the transferred charge and to reduce the output ripple voltage [22].

If the voltage multiplier was in a steady state, RF_{in} was greater than or equal to zero for $0 \le t \le \pi/4$ and $3\pi/4 \le t \le \pi$, and RF_{in} was less than or equal to zero for $\pi/4 \le t \le 3\pi/4$ in the first time cycle T (= 1/f). RF_{in} charged the capacitor C_1 through the MOSFET M_1 for $RF_{in} \le 0$, and a steady voltage of $V_{in} - V_{TH}$ was then stored in C_1 by reducing a threshold voltage V_{TH} . Voltage was subsequently changed to $V_{in} + (V_{in} - V_{TH})$ across the capacitor C_1 for $RF_{in} \ge 0$. M_2 was the conducting MOSFET, and the voltage of C_2 was charged to $2 \times (V_{in} - V_{TH})$ by reducing a threshold voltage V_{TH} of M_2 . In the second time cycle (2T), RF_{in} charged the capacitor C_2 to $V_{in} + 2 \times (V_{in} - V_{TH})$ for $RF_{in} \le 0$, and a steady voltage of $3 \times (V_{in} - V_{TH})$ was passed through M_3 and stored in C_3 . For $RF_{in} \ge 0$, the voltage of C_3 was abruptly changed to $V_{in} + 3 \times (V_{in} - V_{TH})$, and M4 was the conducting MOSFET. A steady voltage of $4 \times (V_{in} - V_{TH})$ was generated across the capacitor C_4 . After the third time cycle (3T) was completed, a steady voltage of $6 \times (V_{in} - V_{TH})$ was generated without a body effect across the load capacitor C_L . The ideal output DC voltage Vdc could be expressed as follows:

$$V_{dc}(V) = 6 \times (V_{in} - V_{TH}),\tag{7}$$

Equation (7) indicates that the larger the threshold voltage V_{TH} is, the smaller the DC output voltage V_{dc} is. Threshold voltage V_{TH} is highly correlational to a semiconductor process. A conventional CMOS has an inherent threshold voltage of approximately 0.45 V for the standard TSMC 0.18 process, whereas a low threshold voltage of 28 mV was obtained using a conventional MOS. The conventional MOS was used to not only develop a new RF-DC rectifier but also to enhance power efficiency, particularly for an ultra-low input power of less than -10 dBm.

2.3. Over-Voltage Protection Circuit

Figure 4 presents an over-voltage protection circuit used to prevent the occurrence of a high-voltage breakdown phenomenon during NFC [19]. The output DC voltage V_{dc} of the RF-DC rectifier was

connected to the proposed protection circuit, and two PMOSs $(M_1 - M_2)$ and two NMOSs $(M_8 - M_9)$ were diode-connected. Two bias voltages V_A and V_B could be expressed as follows:

$$V_A = V_{dc} - (|V_{OD1}| + |V_{tp1}|) - (|V_{OD2}| + |V_{tp2}|),$$
(8)

$$V_B = V_{OD9} + V_{tn9},\tag{9}$$

where V_{ODi} , V_{tpi} , and V_{tni} are the overdrive voltage of the *i*th MOSFET, threshold voltage of the *i*th PMOS, and threshold voltage of the *i*th NMOS. Under a common-mode operation, the two bias voltages were identical (i.e., $V_A = V_B$). The DC output voltage of the RF-DC rectifier can be expressed as follows:

$$V_{dc} = \left(|V_{OD1}| + |V_{tp1}| \right) - \left(|V_{OD2}| + |V_{tp2}| \right) + (V_{OD9} + V_{tn9}), \tag{10}$$

Furthermore, the two bias voltages V_A and V_B could be derived from resistors ($R_1 - R_2$, $R_{ds1} - R_{ds2}$, and $R_{ds8} - R_{ds9}$). Thus, the following can be derived:

$$V_A = \frac{R_1}{R_{ds1} + R_{ds2} + R_1} \times V_{dc},\tag{11}$$

$$V_B = \frac{R_{ds9}}{R_2 + R_{ds8} + R_{ds9}} \times V_{dc},$$
(12)

where R_{dsi} was the conduction impedance of the *i*th diode-connected MOSFET, which is expressed as $(g_{mi} + g_{mbi})^{-1}$ with the transistor transconductance g_{mi} and body effect transconductance g_{mbi} . R_1 and R_2 are constant resistors. The larger the bias current I_{Ri} of the *i*th resistor is, the larger the transconductance g_{mi} is and the smaller the conduction resistor R_{dsi} is.

If the output DC voltage V_{dc} of the RF-DC rectifier was higher than the aforementioned voltage [Equation (11)], the bias voltage V_A was larger than the bias voltage V_B because of the reduced conduction impedance R_{dsi} with the large resistor current I_{Ri} . The difference between V_A and V_B was amplified, and the differential output voltage V_O was used to control the conduction current I_O of the output transistor M_O . The larger the dc voltage V_{dc} is, the larger the conduction current I_O is. Thus, a stable DC output voltage ranged from 1.69 V to 1.76 V with an input power (P_{in}) ranging from –14 dBm to +10 dBm. Please note that the voltage variations of two biased voltages, V_A and V_B , will be suppressed in the PVT (process, supply voltage, and temperature) variation. For example, if the resistor R_1 is reduced with PVT variation, the bias current I_{R1} . As a result, three resistors, R_{ds1} and R_{ds2} , are decreased by the large bias current I_{R1} . As a result, three resistors, R_{ds1} , and R_1 , are reduced simultaneously to suppress the impact of PVT variation.

2.4. Low-Voltage Low-Dropout Regulator

Because of an input voltage with inference and input power limitation, a low-voltage and low-power LDO regulator is required for supplying a stable and clean voltage to the next stage. The designed LDO regulator was used for regulating the output variation in the over-voltage protection circuit and for providing a stable voltage V_{dd} of 1.5 V to the charger control circuit. Figure 5 shows the proposed low-voltage LDO regulator, which includes a reference voltage, a current source, an error amplifier, a pass transistor, a feedback network, frequency compensation, and a load. A CMOS reference voltage V_{ref} was generated and inputted to the positive terminal (+) of an error amplifier (EA). The negative terminal (-) of the EA was connected to the feedback network. A comparison between the reference voltage V_{ref} and a feedback value indicates that the voltage difference between the positive and negative terminals was amplified as an output voltage of the EA, which was connected to a pass transistor for providing a stable supply voltage V_{dd} by controlling the load current flow through the pass transistor [23].

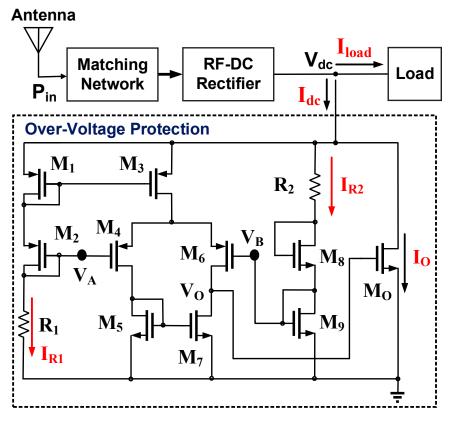


Figure 4. Proposed over-voltage protection circuit.

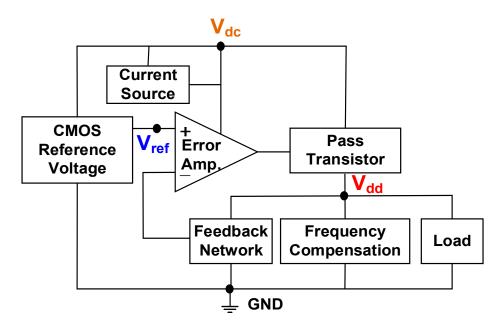


Figure 5. Proposed low-voltage LDO regulator with a reference voltage, a current source, an error amplifier, a pass transistor, a feedback network, frequency compensation, and a load.

Figure 6 shows the complete circuit of the adopted CMOS reference voltage [24]. The supplied voltage V_{dc} could be maintained at a possible voltage of 0.7 V when all transistors operated in the subthreshold region. A compensation capacitor C_C was added between the drain of M_{N1} and ground (GND) to improve circuit stability by increasing the phase margin. Assume that I₂ = $100 \times I_1$, W_{MP2} = $100 \times W_{MP1}$, and W_{MN2} = $100 \times W_{MN1}$. The voltage of node X was equal to that of node Y (i.e., V_X = V_Y).

Thus, the drain–source voltage of M_{P2} ($V_{DS,MP2}$) was equal to that of M_{P3} ($V_{DS,MP3}$). Two bias currents (I_2 and I_3) were identical without channel length modulations of M_{P2} and M_{P3} . If two NMOSFETs operated in the subthreshold region, the voltage difference across the resistor R_1 is given as follows:

$$V_{R1} = V_{GS,MN2} - V_{GS,MN3} = nV_T \times \ln \frac{(W/L)_{MN3}}{(W/L)_{MN2}},$$
(13)

where *n* and V_T are the subthreshold region swing parameter and thermal voltage, respectively. The *n* is a constant and V_T is a parameter independent of the process. Thus, process variations do not influence V_{R1} . $V_{GS, MNi}$ and $(W/L)_{MNi}$ are the gate–source voltage and the ratio of width to length for the transistor M_{Ni} , respectively. Equation (13) indicates that a temperature coefficient (TC) is positive for the resistor's voltage V_{R1} .

Voltage reference V_{ref} can be written as follows:

$$V_{ref} = V_{R2} + V_{GS,MN2} = 2.01 \times \frac{R_2}{R_1} \times V_{R1} + V_{GS,MN2},$$
(14)

where V_{R1} and V_{R2} are voltage differences across resistors R_1 and R_2 , respectively, and $V_{GS,MN2}$ is the gate–source voltage of the transistor M_{N2} with a negative TC. A positive TC was combined with a negative TC in an integrated circuit to obtain the desired reference voltage V_{ref} with zero temperature dependence [24]. The simulation result shows that the reference voltage V_{ref} varied from 499.035 mV to 502. 855 mV with respect to the supplied voltage V_{dc} from 1.7 V to 2.0 V at a quiescent current of 34 nA.

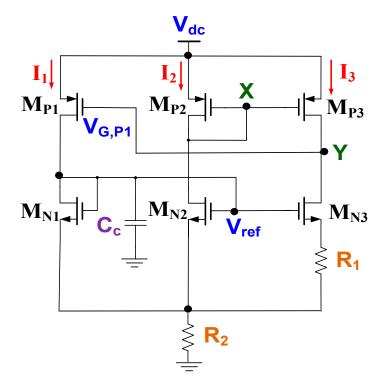


Figure 6. Complete circuit of the adopted CMOS reference voltage.

Figure 7 shows the complete circuit of a low-voltage LDO regulator. The EA was a CMOS two-stage amplifier, which was designed to regulate the supplied output voltage V_{dc} of the low-voltage LDO regulator by controlling the gate voltage of the pass transistor V_{err} . The first stage had a p-channel differential input pair with an n-channel current mirror active load for a high gain A_{V1} . The second stage is generally configured as a simple common source stage to allow maximum output swings with gain A_{V2} [25]. Bias currents were copied through the current source by controlling the resistor R_3 .

The voltage swing at V_{err} was equal to $V_{dc} - |V_{OD,MP6}| - V_{OD,MN6}$ with overdrive voltages, $V_{OD,MP6}$ and $V_{OD,MN6}$, of MP6 and MN6, respectively. The overall voltage gain A_V can be derived as follows:

$$\begin{cases}
A_{v1} = -g_{m,MP7}(r_{ds,MP8} || r_{ds,MN5}) \\
A_{v2} = -g_{m,MN6}(r_{ds,MP6} || r_{ds,MN6}) \\
A_{v} = A_{v1} \times A_{v2}
\end{cases}$$
(15)

where $g_{m,MPi}$ and $r_{ds,MPi}$ are the transconductance and conduction resistance of the *i*th PMOS, respectively. $g_{m,MNi}$ and $r_{ds,MNi}$ are the transconductance and conduction resistance of the *i*th NMOS, respectively.

Zero frequency ω_z can be modified by placing a resistor R_z in series with the compensation capacitor C_Z [26]. If $R_z \ge (g_{m,MN6})^{-1}$, then $\omega_z \le 0$. Zero may be moved into the left-half plane for cancelling the first nondominant pole ω_{p2} . The compensation resistance R_Z is then given as follows:

$$R_z = \frac{1}{g_{m,MN6}} \left(1 + \frac{C_1 + C_2}{C_Z} \right),\tag{16}$$

where C_1 and C_2 are total capacitances at node E before C_Z was added and that at node V_{err}, respectively. Moreover, the increasing C_Z moves the dominant pole to a lower frequency without affecting the second pole. This effect ensures that the designed amplifier is more stable [25]. The simulated results indicate that DC gain, phase margin, and unit-gain bandwidth were 50 dB, 60°, and 1.57 MHz, respectively, at a supplied voltage of 1.7 V and quiescent current of 223.22 nA.

The feedback network was a voltage-trimming network and comprised four diode-connected PMOSs ($M_{P10}-M_{P13}$) and an adjustable voltage, V_A , which is generally connected to a voltage of 1.4 V. Three PMOSs were designed to complete coarse adjustment, whereas the NMOS M_{P10} was used to perform fine-tuning by controlling the adjustable voltage V_A . To stabilize the LDO regulator, phase characteristics were adjusted such that a phase shift was less than 180° at gain crossover. Frequency compensation is completed by connecting a resistor R_F in series with a filter capacitor C_F . The loop gain was zero at $s_z = -(R_F C_F)^{-1}$.

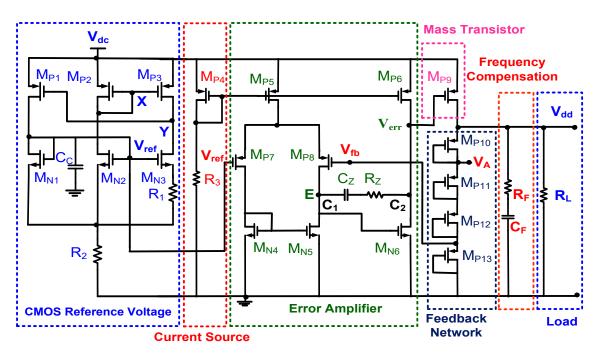


Figure 7. Complete circuit of the low-voltage LDO regulator.

2.5. Charge Control Circuit

Figure 8 presents the charge control circuit, which was used to control the charge in the battery by using the supplied output voltage V_{dd} of the LDO regulator. The control circuit comprised a differential pair (Q_1 – Q_3), current mirror (Q_4 – Q_5), and comparator (Comp) to prevent the overcharging of the battery. Channel length modulation and body effect were assumed negligible, and the differential pair operated in a saturation region. The battery was charged using a constant current, which was generated using Q_1 and Q_2 with two bias voltages (V_{B1} and V_{B2}). When the battery voltage V_{bat} was lower than the reference voltage V_{ref} , the output voltage of the comparator increased to a high level (1) and Q_3 was turned off. Two constant currents of Q_1 and Q_4 simultaneously flowed into Q_2 . The conduction current of Q_5 was amplified N times with (W/L)₅ = N×(W/L)₄ when it was passed through the current mirror Q_4 – Q_5 . This large current rapidly charged the battery. If V_{bat} was higher than V_{ref} , the output voltage of the comparator was low (0) and Q_3 was turned off. Two constant currents of Q_1 and Q_5 were turned off, and the battery was not further charged.

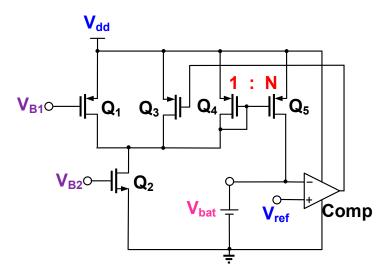


Figure 8. Complete circuit of charge control circuit.

3. Simulated and Measured Results

Figure 9 presents the simulated output voltage of the RF-DC rectifier by using a signal analyzer (EXA N9010A) at a distance of 10.0 cm between the antenna and rectifier. The operating frequency was 915 MHz, and the equivalent load was 1 MΩ. The simulation results revealed a minimum output voltage of 0.746 V at an input power P_{in} of -20 dBm, and a maximum output voltage of 21.693 V at $P_{in} = +20$ dBm. The proposed RF-energy-harvesting chip requires the over-voltage protection circuit to prevent the breakdown phenomenon, which is generated by high output voltages, particularly for NFC. Figure 10 shows the simulated DC output voltages of the RF-DC rectifier with over-voltage protection, which were limited from 1.773 V to 1.809 V with respect to the input power P_{in} from -13 dBm to +20 dBm. Figure 11 presents the simulated *PCE* of the RF-DC rectifier with over-voltage protection, which is termed the rectifier *PCE*. It was approximately 43.601% at an input power of -7 dBm. *PCE* is defined as that in [26]:

$$PCE(\%) = \frac{P_{dc}}{P_{in}} \times 100\% = \frac{I_{dc} \times V_{dc}}{P_{in}} \times 100\%$$
(17)

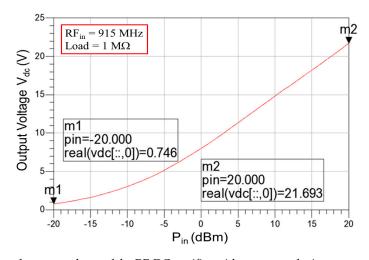


Figure 9. Simulated output voltage of the RF-DC rectifier with respect to the input power from -20 dBm to +20 dBm.

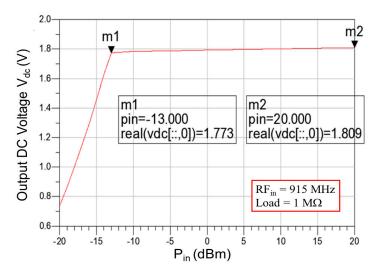


Figure 10. Simulated DC output voltages of the RF-DC rectifier with over-voltage protection.

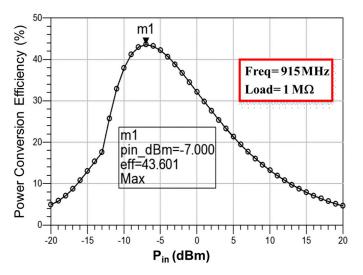


Figure 11. Simulated *PCE* of the RF-DC rectifier with over-voltage protection (rectifier *PCE*), whose *PCE* was approximately 43.6% at the input power of -7 dBm.

The proposed LDO regulator provides a stable output voltage of 1.5 V and a load current of 30 μ A to the next stage-charge control circuit. When the input voltage varied from 1.7 V to 2.0 V and the reference voltage was 1.4 V, the LDO regulator performed with a quiescent current of 317 nA, and a maximum power efficiency of 84.835% was obtained at an input power P_{in} of -10 dBm. Figure 12 shows the simulated line regulation of the proposed LDO regulator. When the input voltage was varied from 1.7 V to 2.0 V, the output voltage changed from 1.5 V to 1.5108 V, and a line regulation of 36 mV/V was obtained. Figure 13 presents the simulated load regulation of the proposed LDO regulator. As the output current varied from 0.0 μ A to 10.0 μ A, the output voltage changed from 1.499952 V to 1.499968 V. A load regulation of 1.6 mV/mA was then obtained [27].

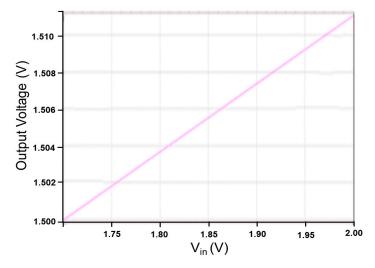


Figure 12. Simulated line regulation of the proposed LDO regulator.

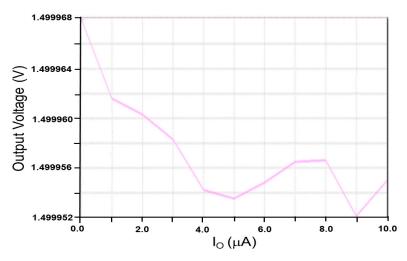


Figure 13. Simulated load regulation of the proposed LDO regulator.

The charge control circuit was inputted with a pulse waveform, which is gradually ramped up from 1.2 V to 1.5 V, to charge the battery with the charging current of 16 μ A. When the battery voltage was charged to 1.4 V at 2.002 ms, the charging current decreased sharply, thereby reducing the charging speed. Finally, the voltage of the battery increased to 1.50 V with zero charging current. Figure 14 shows the simulated battery voltage and charging current of the charger control circuit. The maximum power efficiency of the charge control circuit was 84.835% at an input power *P*_{in} of +20 dBm.

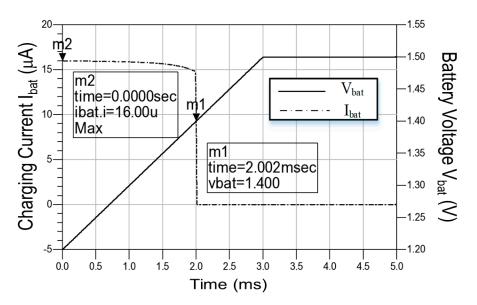


Figure 14. Simulated battery voltage and charging current of the charger control circuit.

When all functional blocks were verified, the RF-energy-harvesting chip could be implemented using the standard TSMC 0.18 µm 1P6M CMOS process. Figure 15 shows the layout of the proposed RF-energy-harvesting IC, which comprised the RF-DC rectifier, over-voltage protection circuit, CMOS voltage reference, LDO regulator, and charge control circuit. The over-voltage protection circuit, low-voltage LDO regulator, and charge control circuit of the RF-DC rectifier required 33 µW, 5 µW, and 4 μ W, respectively, to charge the battery to 24 μ W. The simulation results revealed that charging current was 16 μ A at N = 55, and the over-voltage protection mechanism was started at 2.002 by setting the output voltage of the over-voltage protection circuit, output voltage of the charger control circuit, and reference voltage at 1.7 V, 1.5 V, and 1.4 V, respectively. Figure 16 shows the simulated total power conversion efficiency of the proposed RF-energy-harvesting IC, which was termed the system *PCE*. The maximum system *PCE* was 29.873% at an input power P_{in} of -12 dBm. The maximum rectifier PCE was reduced to the same value at $P_{in} = -12$ dBm by integrating all designed circuits into a single chip (Figure 11). Table 1 summarizes the performance and compares it with that of other RF-DC rectifiers. The simulated maximum rectifier PCE in this study was superior to the PCEs of previously published RF-DC rectifiers. Table 2 presents the simulated specifications of the proposed RF-energy-harvesting IC.

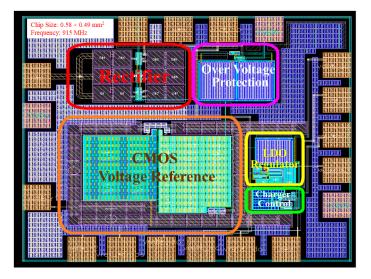


Figure 15. Layout of the proposed RF-energy-harvesting IC.

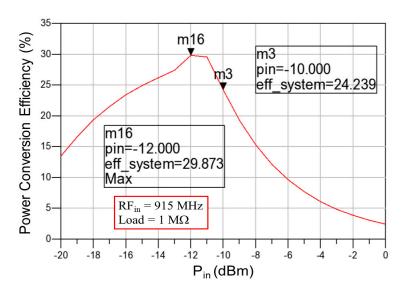


Figure 16. Simulated total PCE of the proposed RF-energy-harvesting IC.

Table 1. Summary of performance and its comparison with those of previous RF-DC rectifiers.

Reference (year)	[19] 2013	[28] (2014)	[29] (2017)	This Work
Process	0.18 μm	0.18 μm	65 nm	0.18 μm
Input power	−7 dBm	-21.2 dBm	−17.7 dBm	−7 dBm
RF frequency	5.2 GHz	925 MHz	900 MHz	915 MHz
Rectifier stages	5	7	5	6
Matching circuit	On-chip	Off-chip	Off-chip	Off-chip
Maximum PCE	42%	43%	36.5%	43.6%

Table 2. Simulated specifications of the proposed RF-energy-harvesting IC.

Parameters	Designed Specifications		
Technology process	TSMC 0.18 µm 1P6M CMOS process		
RF frequency (f_{in})	915 MHz		
Input power range (P_{in})	−13 ~ +20 dBm		
Output dc voltage (V _{dc})	1.773 ~ 1.809 V		
Maximum PCE of rectifier	43.603%		
LDO output voltage (V _{dd})	1.50 V		
Charging current (Ibat)	16 μΑ		
Maximum PCE of RF IC	29.873%		
Chip area (include pads)	$0.58 \times 0.49 \text{ mm}^2$		

The matching network was completed with off-chip components to have an input impedance of approximately 50 Ω . Figure 17 shows the matching network, which was designed to obtain not only maximum power transfer but also maximum conversion efficiency. The E5071C network analyzer was used to measure the input impedance against various input powers. Moreover, multiple sets of matching circuits were designed to ensure that each set of the matching circuit exhibited an input return loss (S₁₁) of less than –25 dB. For example, an input impedance of 51.464 – j × 1.3071 could be achieved with an input return loss (S₁₁) of –34.271 dB by putting a parallel inductance (L) of 7.5 nH and a series capacitance (c) of 22 pF on a printed circuit board (PCB). Figure 18 shows the measured input return loss in the Z-smith chart at an input power and RF frequency of 0 dBm and 915.0000 MHz, respectively.

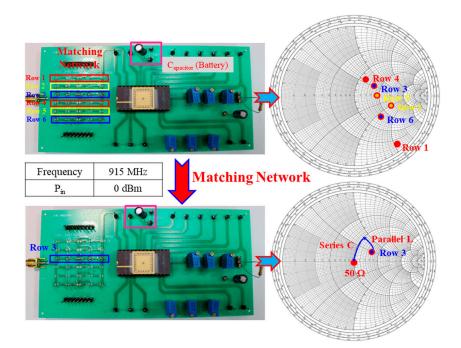


Figure 17. Matching network used to obtain an input impedance of approximately 50Ω .

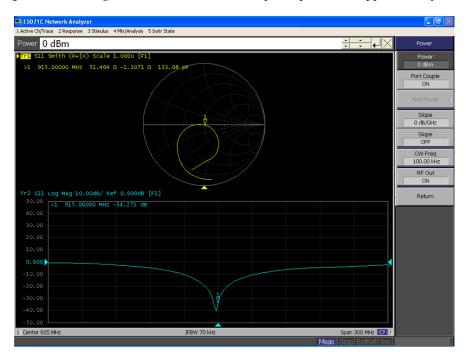


Figure 18. Measured results in the Z-smith chart at an input power of 0 dBm and RF of 915.0000 MHz.

Figure 19 shows the measurement platform of the designed RF-energy-harvesting IC with capacitor, which includes the PCB ($15.576 \times 7.906 \text{ cm}^2$), network analyzer (Agilent E5071C), RF-IC ($0.58 \times 0.49 \text{ mm}^2$), Powercast transmitter (TX91501), and multimeter (CNN 38). By connecting the receiving antenna to the matching network on the measured PCB, the multimeter measures the output voltage of approximately 1.702 V by setting a distance of 2.45 m between the Powercast transmitter and PCB, with an input power of 0.0 dBm. Figure 20 shows the measured setup of the proposed RF-energy-harvesting IC.

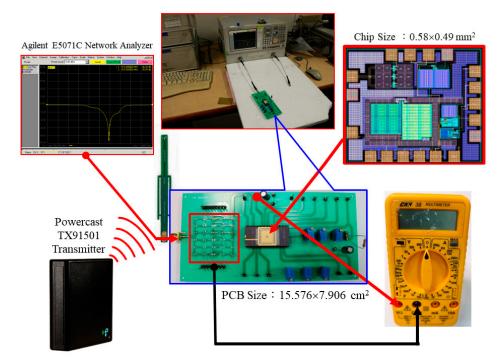


Figure 19. Measurement platform of the designed RF-energy-harvesting IC with capacitor.

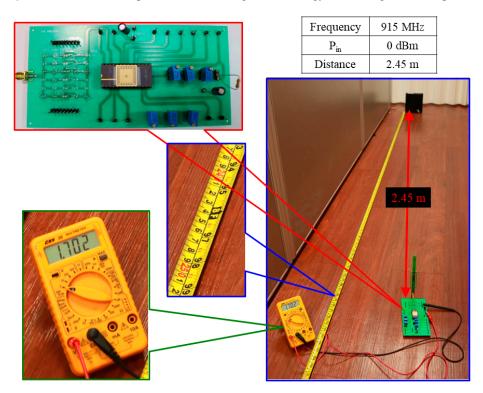


Figure 20. Measured setup of the proposed RF-energy-harvesting IC.

Table 3 summarizes the results for the designed RF-DC rectifier with the over-voltage protection circuit. Because the distance between the Powercast transmitter and test PCB was provided, the input power P_{in} (dBm), input return loss S_{11} (dB), and DC output voltage V_{dc} (V) were measured after the input impedance Z_{in} (Ω) and its corresponding matching circuits [L (nH) and C (pF)] were completed. The results showed that the DC output voltage V_{dc} varied from 0.291 V to 1.725 V with respect to the distance from 5.45 m to 0.55 m. The measured output voltages were lower than the simulated

results. A stable charging voltage V_{dd} can be obtained through the LDO regulator. Figure 21 shows the measured DC output voltage Vdc of the designed RF-DC rectifier with the over-voltage protection circuit with respect to the input power P_{in} from -20 dBm to +10 dBm. Please note that the measured DC output voltages were limited from 1.682 V to 1.725 V with respect to the input power from -2 dBm to +10 dBm in Figure 21.

Table 3. Measured input power P_{in} (dBm), input return loss S_{11} (dB), and output DC voltage V_{dc} (V) with respect to distance (m) between the transmitter and test PCB, input impedance Z_{in} (Ω) and its corresponding matching circuits [L (nH) and C (pF)] for the RF-DC rectifier with the over-voltage protection circuit.

Distance (m)	$Z_{in}(\Omega)$ -	Matching Circuits		D (dPm)	C (1D)	
		Parallel (L)	Series (C)	P _{in} (dBm)	S ₁₁ (dB)	V _{dc} (V)
5.45	50.548 – j × 2.294	2.4 nH	38 pF	-20	-28.1	0.291
5.12	52.043 – j × 2.893	3.6 nH	32 pF	-17	-28.4	0.535
4.66	$53.916 - j \times 1.260$	6.8 nH	29 pF	-14	-32.6	0.792
4.25	51.784 – j × 2.789	8.6 nH	26 pF	-11	-29.8	1.019
3.93	52.784 – j × 2.699	6.6 nH	24 pF	-8	-28.4	1.223
3.60	$48.561 - j \times 6.422$	5.6 nH	22 pF	-5	-33.0	1.450
3.30	$52.109 + j \times 3.382$	5.6 nH	22 pF	-4	-28.3	1.509
3.15	$53.942 - j \times 1.324$	6.2 nH	22 pF	-3	-28.0	1.623
2.90	$54.226 + j \times 2.072$	6.2 nH	22 pF	-2	-26.9	1.682
2.70	53.369 – j × 11.324	6.8 nH	22 pF	-1	-29.0	1.700
2.45	$51.464 - j \times 1.307$	7.5 nH	22 pF	0	-34.3	1.702
2.25	$51.581 + j \times 7.158$	10 nH	10 pF	1	-35.4	1.706
1.68	$49.710 - j \times 4.909$	10 nH	10 pF	2	-26.1	1.712
1.50	$53.573 + j \times 1.835$	12 nH	10 pF	3	-28.2	1.714
1.00	54.669 – j × 1.756	22 nH	10 pF	6	-26.4	1.716
0.68	53.350 – j × 2.136	68 nH	10 pF	9	-28.3	1.723
0.55	$50.655 - j \times 4.093$	100 nH	10 pF	10	-27.7	1.725

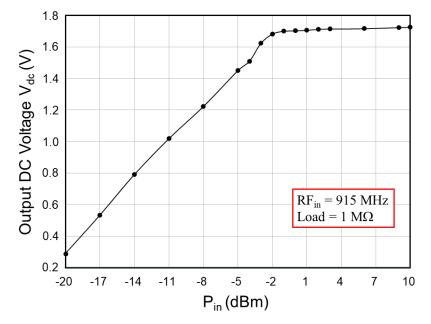


Figure 21. Measured DC output voltages of the RF-DC rectifier with over-voltage protection with respect to the input power.

Finally, the simulated rectifier *PCE* was 43.601% at an input power P_{in} of -7 dBm, and the simulated system *PCE* was 29.873% at an input power P_{in} and a load resistor of -12 dBm and 1 M Ω ,

the input power is. A large load resistor reduces load current, whereas it increases charging current I_{bat} for the abrupt charging of the battery. This phenomenon provides the maximum system *PCE* at a low input power. A trade-off was observed between the load resistor and the maximum system *PCE*. Moreover, the results indicate that the largest system *PCE* of 40.556% was observed at a load resistor of 30 k Ω and an input power P_{in} of -6 dBm.

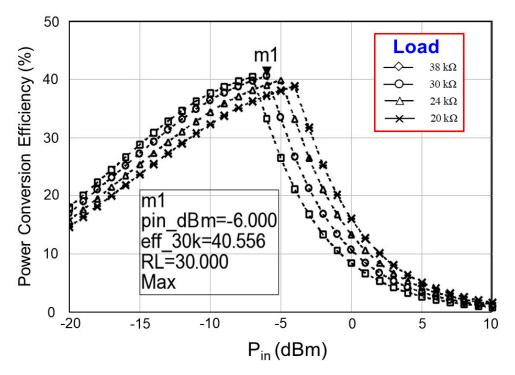


Figure 22. Measured *PCE* of the proposed RF-energy-harvesting IC (system *PCE*) with respect to the input power (dBm) and load resistor (Ω).

Table 4 shows the measured electrical characterizations of the proposed RF-energy-harvesting IC, which includes the power consumption, power delivery, and other electrical characterization facts. Table 5 summarizes the performance and compares the performance with that of other RF-DC rectifiers and RF-energy-harvesting ICs. The maximum rectifier *PCE* obtained in this study was superior to that in [30], and the maximum *PCE* of the RF-energy-harvesting IC was superior to that in [31]. Several RF-DC rectifiers have been studied in the past few years; however, studies on system integration, such as RF-energy-harvesting ICs, have been rare. Furthermore, the IC proposed in this study exhibited low power consumption and a small chip area. It is possible to decrease the labor cost significantly by eliminating the future maintenance efforts to replace batteries. At close range, this proposed IC can be used to trickle charge for low power devices including GPS, tracking tags, wearable sensors, and consumer electronics. At long range, this transmitted power can be used for battery-based or battery-free remote sensors for factory automation, structural health monitoring, and industrial control. In future work, the power conversion efficiencies (*PCEs*) of the rectifier and RF-energy harvesting chip can be improved by reducing the energy consumption of each proposed circuit.

Parameters (unit)	Values	
RF frequency (MHz)	915	
Input impedance (Ω)	$51.464 - j \times 1.3071$	
Input power (dBm)	0	
Distance between Powercastand PCB (m)	2.45	
Matching components	L = 7.5 nH and $C = 22 pF$	
Load resistor ($k\Omega$)	30	
Measured PCB (cm ²)	15.576×7.906	
Maximum PCE	$40.566\% @P_{in} = -6 \text{ dBm}$	
Output voltage (V)	1.50	
Power consumption (μ W)	42	
Chip area (mm ²)	0.58×0.49	

Table 4. Measured electrical	characterizations of the	proposed RF-energy-	harvesting IC.
Tuble 1. Micubalea electrica	characterizations of the	proposed in chergy	nul v coung i c.

Table 5. Summary of performance and its comparison with those of other RF-DC rectifiers and RF-energy-harvesting ICs.

Reference (year)	[30] (2018)	[31] (2018)	[32] (2016)	[33] (2017)	This Work
Process (µm)	0.13	0.18	0.18	0.13	0.18
RF frequency (MHz)	915	900	900	2000	915
Matching circuits	Off-chip	Off-chip	Off-chip	Off-chip	Off-chip
Input power range (dBm)	-35 ~ -15	-30 ~ +0	-26 ~ -8	-35 ~ +5	-20 ~ +10
Stages (Rectifier)	10	5	2	3	6
Maximum PCE	$42.8\%@P_{in} =$		$78.2\%@P_{in} =$	$73.9\%@P_{in} =$	$43.6\%@P_{in} =$
(Rectifier)	-16 dBm	—	-12 dBm	4.34 dBm	−7 dBm
Output voltage (V) (Rectifier)	2.32	_	1.0	3.5	1.725
Maximum <i>PCE</i> (RF harvesting IC)	_	$32.8\%@P_{in} = -2 dBm$	_	_	$40.56\%@P_{in} = -6 \text{ dBm}$
Output voltage (V)(RF harvesting IC)	—	1.77	—	—	1.50
Load resistor $(k\Omega)$	500	500	—	2	30
Chip area (mm ²)	0.0296	16.56	—	0.954	0.2842
Power (µW)	—	_	—	_	42

4. Conclusions

This study proposed an auxiliary power integrated chip (IC) to supply power to the WSN with a Power cast transmitter of ISM 915 MHz. The RF-energy-harvesting IC was designed and fabricated using the standard TSMC 0.18 μm 1P6M CMOS process. The externally matched capacitors and inductors were manufactured in the matching network by MuRata Company. On integrating the externally matched components with the designed RF-energy-harvesting IC, the simulated results showed that the maximum PCEs of the rectifier and harvesting IC were 43.6% and 29.873%, respectively, at an ISM band of 915 MHz, an input power of -7 dBm, and a load of 1 M Ω . The output voltage of the RF-DC rectifier with the over-voltage protection circuit was limited from 1.773 V to 1.809 V with the varying input power from -10 dBm to +20 dBm. A stable voltage of 1.5 V was supplied to the charge control circuit passing through the LDO circuit. Measurements validated that the designed RF-energy-harvesting IC works successfully. The output voltage V_{dc} varied from 0.291 V to 1.725 V with respect to the distance from 5.45 m to 0.55 m. The large load resistor reduced load current; however, it sharply increased the charging current to charge the battery abruptly. This phenomenon provided the maximum system *PCE* at low input power. A trade-off was observed between the load resistor and the maximum system PCE. Furthermore, the maximum rectifier PCE of this study was superior to that in [30], and the maximum PCE of the RF-energy-harvesting IC was superior to that in [31]. Measurements indicate that the IC used in this study exhibited low power consumption and a small chip area. The proposed energy harvesting IC can be used in both ambient source and dedicated

source [34]. Another possibility offered by the use of microelectronic substrates is on-chip photovoltaic generation with integrated photodiodes [35,36].

Author Contributions: This study was completed by four authors. Y.-J.L. and J.-Y.S. designed and implemented the proposed chip; C.-K.C. completed the system integration and measurements; and G.-M.S. analyzed the data and wrote the paper.

Acknowledgments: The authors would like to thank the Chip Implementation Center, Taiwan, for fabricating the test chip. They are grateful to Wallace Academic Editing for editing this manuscript.

Conflicts of Interest: The authors declare no conflict of interest.

References

- Bito, J.; Hester, J.G.; Tentzeris, M.M. Ambient RF energy harvesting from a two-way talk radio for flexible wearable wireless sensor devices utilizing inkjet printing technologies. *IEEE Trans. Microw. Theory Tech.* 2015, 63, 4533–4543. [CrossRef]
- Tian, M.; Wang, N.; Wang, K.; Jia, H.; Li, Z.; Yang, X.; Wang, L. A wire-embedded converter used for wearable devices. In Proceedings of the IEEE Applied Power Electronics Conference and Exposition (APEC), Tampa, FL, USA, 26–30 March 2017; pp. 121–125.
- Nguyen, S.H.; Ellis, N.; Amirtharajah, R. Powering smart jewelry using an RF energy harvesting necklace. In Proceedings of the IEEE MTT-S International Microwave Symposium (IMS), San Francisco, CA, USA, 22–27 May 2016; pp. 1–4.
- 4. Rastmanesh, M. High Efficiency RF to DC Converter with Reduced Leakage Current for RFID Applications. Master's Thesis, Dalhousie University, Halifax, NS, Canada, April 2013.
- 5. Le, T.; Mayaram, K.; Fiez, T. Efficient far-field radio frequency energy harvesting for passively powered sensor networks. *IEEE J. Solid-State Circuits* **2008**, *43*, 1287–1302. [CrossRef]
- 6. Papotto, G.; Carrara, F.; Palmisano, G. A 90-nm CMOS threshold-compensated RF energy harvester. *IEEE J. Solid-State Circuits* **2011**, *46*, 1985–1997. [CrossRef]
- Udupa, S.S.; Sushma, P.S. An orthogonally switching charge pump rectifier for RF energy harvester. In Proceedings of the 2nd IEEE International Conference on Recent Trends in Electronics Information & Communication Technology (RTEICT), Bangalore, India, 19–20 May 2017; pp. 447–450.
- Pasha, M.A.; Derrien, S.; Sentieys, O. A complete design-flow for the generation of ultra low-power WSN node architectures based on micro-tasking. In Proceedings of the Design Automation Conference, Anaheim, CA, USA, 13–18 June 2010; pp. 693–698.
- Shigeta, R.; Sasaki, T.; Quan, D.M.; Kawahara, Y.; Vyas, R.J.; Tentzeris, M.M.; Asami, T. Ambient RF energy harvesting sensor device with capacitor-leakage-aware duty cycle control. *IEEE Sens. J.* 2013, 13, 2973–2983. [CrossRef]
- Harpawi, N. Design energy harvesting device of UHF TV stations. In Proceedings of the 2014 8th International Conference on Telecommunication Systems Services and Applications (TSSA), Denpasar, Indonesia, 23–24 October 2014; pp. 1–6.
- 11. Jesus, A.L.G.; Agustin, C.L.; Angel, F.M.; Javier, J.M.F.; Marco, T.P.; Antonia, C.C.; Alfredo, M.S.; Jaime, A.Q. Medium and short wave RF energy harvester for powering wireless sensor networks. *Sensors* **2018**, *18*, 768.
- 12. Vullers, R.J.M.; Van Schaijk, R.; Doms, I.; Van Hoof, C.; Mertens, R. Micropower energy harvesting. *Solid State Electron.* **2009**, *53*, 684–693. [CrossRef]
- 13. Harb, A. Energy harvesting: State-of-the-art. Renew. Energy 2011, 36, 2641–2654. [CrossRef]
- 14. Piñuela, M.; Mitcheson, P.D.; Lucyszyn, S. Ambient RF energy harvesting in urban and semi-urban environments. *IEEE Trans. Microw. Theory Tech.* **2013**, *61*, 2715–2726.
- 15. Zhang, Y.; Zhang, F.; Shakhsheer, Y.; Silver, J.D.; Klinefelter, A.; Nagaraju, M.; Boley, J.; Pandey, J.; Shrivastava, A.; Carlson, E.J.; et al. A batteryless 19 uW MICS/ISM-band energy harvesting body sensor node SoC for ExG applications. *IEEE J. Solid-State Circuits* **2013**, *48*, 199–213. [CrossRef]
- 16. Zeng, Z.; Li, X.; Bermak, A.; Tsui, C.Y.; Ki, W.H. A WLAN 2.4-GHz RF energy harvesting system with reconfigurable rectifier for wireless sensor network. In Proceedings of the 2016 IEEE International Symposium on Circuits and Systems (ISCAS), Montreal, QC, Canada, 22–25 May 2016; pp. 1–5.

- Aboueidah, H.; Abbas, N.; El-Nachar, N.; Al-Yousef, A.; Alhawari, M.; Mohammad, B.; Saleh, H.; Assaf, T.; Ismail, M. Characterization of RF energy harvesting at 2.4 GHz. In Proceedings of the 24th IEEE International Conference on Electronics, Circuits and Systems (ICECS), Batumi, Georgia, 5–8 December 2017; pp. 446–449.
- RF Energy Harvesting and Wireless Power for Micro-Power Applications/Powercaster Transmitter/TX91501-3W User Manual. Powercast Corp. 2018. Available online: http://www.powercastco.com/products/ powercaster-transmitter/ (accessed on 1 January 2019).
- Ouda, M.H.; Arsalan, M.; Marnat, L.; Shamim, A.; Salama, K.N. 5.2-GHz RF power harvester in 0.18 um CMOS for implantable intraocular pressure monitoring. *IEEE Trans. Microw. Theory Tech.* 2013, 61, 2177–2184. [CrossRef]
- 20. Yuan, F.; Soltani, N. Design techniques for power harvesting of passive wireless microsensors. In Proceedings of the 51st Midwest Symposium on Circuits and Systems, Knoxville, TN, USA, 10–13 August 2008; pp. 289–293.
- 21. Hsieh, P.H.; Chou, C.H.; Chiang, T. An RF energy harvester with 44.1% PCE at input available power of-12 dBm. *IEEE Trans. Biomed. Circuits Syst.* **2015**, *62*, 1528–1537. [CrossRef]
- 22. Yi, J.; Ki, W.H.; Tsui, C.Y. Analysis and design strategy of UHF micro-power CMOS rectifiers for micro-sensor and RFID applications. *IEEE Trans. Circuits Syst. I Regul. Pap.* **2007**, *54*, 153–166. [CrossRef]
- Liu, C.C.; Chen, C.H. An ultra-low power voltage regulator for RFID application. In Proceedings of the IEEE 56th International Midwest Symposium on Circuits and Systems (MWSCAS), Columbus, OH, USA, 4–7 August 2013; pp. 780–783.
- 24. Zhuang, H.; Zhu, Z.; Yang, Y. A 19-nW 0.7-V CMOS voltage reference with no amplifiers and no clock circuits. *IEEE Trans. Circuits Syst. II Express Briefs* **2014**, *61*, 830–834. [CrossRef]
- 25. Razavi, B. Design of Analog CMOS Integrated Circuits; International Edition; McGRAW-HILL: New York, NY, USA, 2001.
- Sun, M.; Ranasinghe, D.; Said, F.; Al-Sarawi, S.F. RF energy harvester with peak power conversion efficiency tracking. In Proceedings of the IEEE Asia Pacific Conference on Circuits and Systems (APCCAS), Jeju, Korea, 25–28 October 2016; pp. 107–110.
- 27. Li, M.; Zhou, Y.; Wang, D.; Yuan, S.; Luan, W.; Lin, X.; Wang, Z.; Zhang, C.; Xie, X. A max mode control LDO with a good behavior at PSRR and line regulation and load regulation. In Proceedings of the 13th International Conference on Electron Devices and Solid-State Circuits (EDSSC), Hsinchu, Taiwan, 18–20 October 2017; pp. 1–2.
- 28. Yao, C.Y.; Hsia, W.C. A-21.2 dBm dual-channel UHF passive CMOS RFID tag design. IEEE Trans. Circuits Syst. I Regul. Pap. 2014, 61, 1269–1279. [CrossRef]
- 29. Lu, Y.; Dai, H.; Huang, M.; Law, M.K.; Sin, S.W.; U, S.P.; Martins, R.P. A wide input range dual-path CMOS rectifier for RF energy harvesting. *IEEE Trans. Circuits Syst. II Express Briefs* **2017**, *64*, 166–170.
- Noghabaei, S.M.; Radin, R.L.; Savaria, Y.; Sawan, M. A high-efficiency ultra-low-power CMOS rectifier for RF energy harvesting applications. In Proceedings of the IEEE International Symposium on Circuits and Systems (ISCAS), Florence, Italy, 27–30 May 2018; pp. 1–4.
- Chang, Y.W.; Yu, M.C.; Lin, H.J.; Li, C.H. Compact low-cost five-band RF energy harvester using system-in-package integration. In Proceedings of the IEEE Radio and Wireless Symposium (RWS), Anaheim, CA, USA, 15–18 January 2018; pp. 284–286.
- 32. Vamsi, N.; Priya, V.; Dutta, A.; Singh, S.G. A 1 V, –26 dBm sensitive auto configurable mixed converter mode RF energy harvesting with wide input range. In Proceedings of the IEEE International Symposium on Circuits and Systems (ISCAS), Montreal, QC, Canada, 22–25 May 2016; pp. 1534–1537.
- 33. Moghaddam, A.K.; Chuah, J.H.; Ramiah, H.; Ahmadian, J.; Mak, P.I.; Rui, P.; Martins, R.P. A 73.9%-efficiency CMOS rectifier using a lower DC feeding (LDCF) self-body-biasing technique for far-field RF energy-harvesting systems. *IEEE Trans. Circuits Syst. I Regul. Pap.* **2017**, *64*, 992–1002. [CrossRef]
- Lau, W.W.Y.; Siek, L. 2.45 GHz wide input range CMOS rectifier for RF energy harvesting. In Proceedings of the 2017 IEEE Wireless Power Transfer Conference (WPTC), Taipei, Taiwan, 10–12 May 2017; pp. 1–4.

- 35. Dallago, E.; Barnabei, A.L.; Liberale, A.; Malcovati, P.; Venchi, G. An interface circuit for low-voltage low-current energy harvesting systems. *IEEE Trans. Power Electron.* **2015**, *30*, 1411–1420. [CrossRef]
- 36. Ghosh, S.; Wang, H.T.; Leon-Salas, W.D. A circuit for energy harvesting using on-chip solar cells. *IEEE Trans. Power Electron.* **2014**, *29*, 4658–4671. [CrossRef]



© 2019 by the authors. Licensee MDPI, Basel, Switzerland. This article is an open access article distributed under the terms and conditions of the Creative Commons Attribution (CC BY) license (http://creativecommons.org/licenses/by/4.0/).